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# FDS8947A Dual P-Channel Enhancement Mode Field Effect Transistor

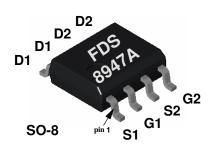
## **General Description**

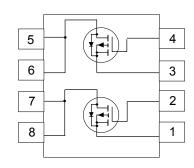
SO-8 P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance and provide superior switching performance. These devices are particularly suited for low voltage applications such as notebook computer power management and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

### **Features**

- High density cell design for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability in a widely used surface mount package.
- Dual MOSFET in surface mount package.







## **Absolute Maximum Ratings** $T_A = 25^{\circ}\text{C}$ unless other wise noted

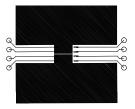
| Symbol            | Parameter                               |           | FDS8947A   | Units |
|-------------------|---|-----------|------------|-------|
| V <sub>DSS</sub>  | Drain-Source Voltage                    |           | -30        | V     |
| V <sub>GSS</sub>  | Gate-Source Voltage                     |           | -20        | V     |
| I <sub>D</sub>    | Drain Current - Continuous              | (Note 1a) | - 4.0      | А     |
|                   | - Pulsed                                |           | -20        |       |
| <b>D</b>          | Power Dissipation for Dual Operation    |           | 2          | W     |
|                   | Power Dissipation for Single Operation  | (Note 1a) | 1.6        |       |
|                   |   | (Note 1b) | 1          |       |
|                   |   | (Note 1c) | 0.9        |       |
| $T_J$ , $T_{STG}$ | Operating and Storage Temperature Range |           | -55 to 150 | °C    |
| THERMA            | L CHARACTERISTICS                       | •         |            | •     |
| $R_{\theta JA}$   | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78         | °C/W  |
| R <sub>eJC</sub>  | Thermal Resistance, Junction-to-Case    | (Note 1)  | 40         | °C/W  |

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| Symbol                           | Parameter   | Conditions  | Min | Тур   | Max   | Units   |
|----------------------------------|---|---|-----|-------|-------|---------|
| OFF CHAR                         | ACTERISTICS   |   |     |       |       |         |
| BV <sub>DSS</sub>                | Drain-Source Breakdown Voltage                          | $V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$        | -30 |       |       | V       |
| $\Delta BV_{DSS}/\Delta T_{J}$   | Breakdown Voltage Temp. Coefficient                     | $I_D$ = -250 $\mu$ A, Referenced to 25 °C               |     | -23   |       | mV / °C |
| I <sub>DSS</sub>                 | Zero Gate Voltage Drain Current                         | V <sub>DS</sub> = -24 V, V <sub>GS</sub> = 0 V          |     |       | -1    | μA      |
| I <sub>GSSF</sub>                | Gate - Body Leakage, Forward                            | V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V           |     |       | -100  | nA      |
| I <sub>GSSR</sub>                | Gate - Body Leakage, Reverse                            | V <sub>GS</sub> = -20 V, V <sub>DS</sub> = 0 V          |     |       | -100  | nA      |
| ON CHARA                         | CTERISTICS (Note 2)                                     | •   |     |       |       |         |
| $V_{GS(th)}$                     | Gate Threshold Voltage                                  | $V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$             | -1  | -1.5  | -3    | V       |
| $\Delta V_{GS(th)}/\Delta T_{J}$ | Gate Threshold Voltage Temp. Coefficient                | I <sub>D</sub> =-250 μA, Referenced to 25 °C            |     | 4     |       | mV /°C  |
| R <sub>DS(ON)</sub>              | Static Drain-Source On-Resistance                       | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -4 A          |     | 0.044 | 0.052 | Ω       |
|                                  |   | T <sub>J</sub> =125°C                                   |     | 0.06  | 0.085 |         |
|                                  |   | $V_{GS} = -4.5 \text{ V}, I_{D} = -3.2 \text{ A}$       |     | 0.067 | 0.08  |         |
| I <sub>D(ON)</sub>               | On-State Drain Current                                  | V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -5 V         | -20 |       |       | Α       |
| g <sub>FS</sub>                  | Forward Transconductance                                | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -4 A          |     | 8     |       | S       |
| DYNAMIC (                        | CH ARACTERISTICS  | •   |     |       |       |         |
| C <sub>iss</sub>                 | Input Capacitance                                       | $V_{DS} = -15 \text{ V}, \ V_{GS} = 0 \text{ V},$       |     | 730   |       | pF      |
| C <sub>oss</sub>                 | Output Capacitance                                      | f = 1.0 MHz   |     | 400   |       | pF      |
| C <sub>rss</sub>                 | Reverse Transfer Capacitance                            |   |     | 90    |       | pF      |
| SWITCHING                        | CHARACTERISTICS (Note 2)                                |   |     |       |       |         |
| t <sub>D(on)</sub>               | Turn - On Delay Time                                    | $V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ A}$          |     | 11    | 20    | ns      |
| t,                               | Turn - On Rise Time                                     | $V_{GS} = -10 \text{ V}$ , $R_{GEN} = 6 \Omega$         |     | 10    | 18    |         |
| t <sub>D(off)</sub>              | Turn - Off Delay Time                                   |   |     | 90    | 110   |         |
| ţ,                               | Turn - Off Fall Time                                    |   |     | 55    | 80    |         |
| $\overline{Q_g}$                 | Total Gate Charge                                       | $V_{DS} = -10 \text{ V}, I_{D} = -4 \text{ A},$         |     | 19    | 27    | nC      |
| $Q_{gs}$                         | Gate-Source Charge                                      | V <sub>GS</sub> = -10 V                                 |     | 3.5   |       |         |
| $Q_{gd}$                         | Gate-Drain Charge                                       |   |     | 3.6   |       |         |
| DRAIN-SOU                        | RCE DIODE CHARACTERISTICS AND MAXI                      | IMUM RATINGS  |     |       |       |         |
| S                                | Maximum Continuous Drain-Source Diode Forward Current   |   |     |       | -1.3  | Α       |
| $V_{SD}$                         | Drain-Source Diode Forward Voltage                      | V <sub>GS</sub> = 0 V, I <sub>S</sub> = -1.3 A (Note 2) |     | -0.75 | -1.2  | V       |
| t <sub>rr</sub>                  | Reverse Recovery Time                                   | $V_{GS} = 0 \text{ V}, I_F = -1.3 \text{ A}$            |     | 48    | 100   | ns      |
| Irr                              | Reverse Recovery Current dl <sub>F</sub> /dt = 100 A/μs |   |     | 0.8   |       | Α       |

#### Notes:

<sup>1.</sup>  $R_{\rm gal}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\rm gal}$  is guaranteed by design while  $\boldsymbol{R}_{\theta\text{CA}}$  is determined by the user's board design.







Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2.0%.

## **Typical Electrical Characteristics**

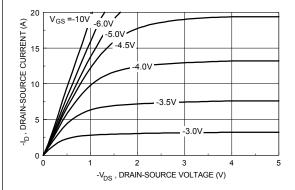


Figure 1. On-Region Characteristics.

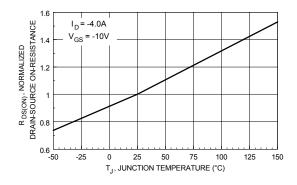


Figure 3. On-Resistance Variation with Temperature.

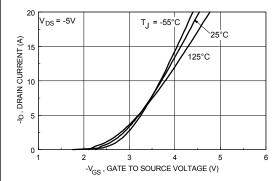


Figure 5. Transfer Characteristics.

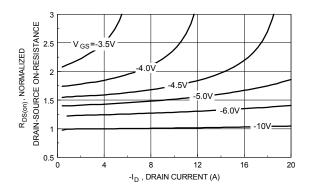


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

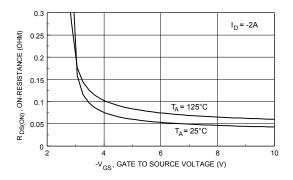


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

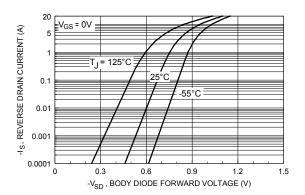


Figure 6 . Body Diode Forward Voltage
Variation with Source Current
and Temperature.

## Typical Electrical Characteristics (continued)

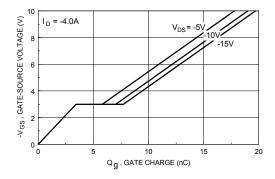


Figure 7. Gate Charge Characteristics.

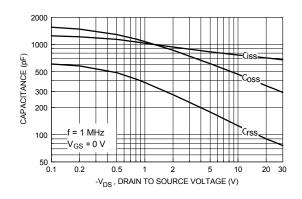


Figure 8. Capacitance Characteristics.

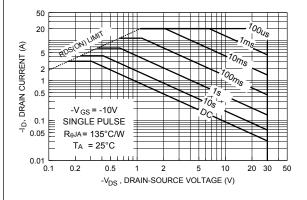


Figure 9. Maximum Safe Operating Area.

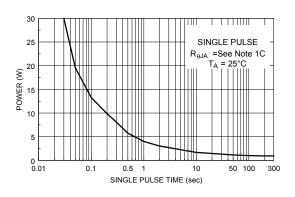


Figure 10. Single Pulse Maximum Power Dissipation.

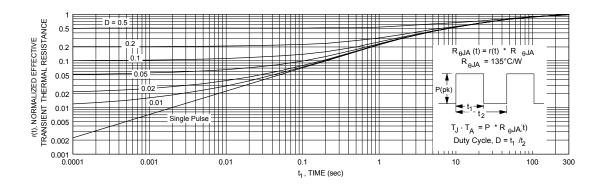


Figure 11. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.

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| Bottomless™       | FAST®                          | LittleFET™         | Power247™           | SuperSOT™-3           |
| CoolFET™          | FASTr™                         | MicroFET™          | PowerTrench®        | SuperSOT™-6           |
| CROSSVOLT™        | FRFET™                         | MicroPak™          | QFET™               | SuperSOT™-8           |
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| $E^2CMOS^{TM}$    | HiSeC™                         | MSXPro™            | Quiet Series™       | TruTranslation™       |
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| Across the board. | Around the world.™             | OCXPro™            | RapidConnect™       | UltraFET <sup>®</sup> |
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| Programmable Ac   | tive Droop™                    | OPTOPLANAR™        | SMART START™        |                       |
|                   |                                |                    |                     |                       |

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